Search Notes

Application/Control No.	Applicant(s)/Patent und Reexamination		
10/044,541	YAMAKAWA ET AL.		
Examiner	Art Unit		
lana N le	2685		

SEARCHED					
Class	Subclass	Date	Examiner		
333	185	2/10/2006	L.L.		
	134				
	126				
	129				
	204				
	205				
455	323				
	25				
	83				
361	311				
	313				
	320				

INTERFERENCE SEARCHED						
Class		Subclass	Date		Examiner	
455		323	2/10/2006		L.L.	
		25				
		83			. 1	
33	3	185				
36	1	311				

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
East -subclasses -keywords	2/10/2006	L.L.	